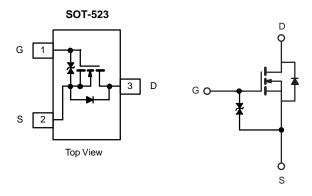


N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A) ^c	Q _g (TYP.)		
20	0.273 at V _{GS} = 4.5 V	1.6	1.4 nC		
	0.399 at V _{GS} = 2.5 V	1.3	1.4110		



FEATURES

- DT-Trench Power MOSFET
- 100 % R_a tested
- Gate-Source ESD Protected



RoHS

APPLICATIONS

- Smart phones, tablet PC's
 - DC/DC converters
 - Boost converters
 - Load switch, OVP switch

PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	20	V
Gate-Source Voltage		V _{GS}	± 8	v
	T _C = 25 °C		1.8	
Continuous Prain Current (T. – 150 °C)	T _C = 70 °C		1.5	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	1.5 ^{a, b}	
	T _A = 70 °C		1.2 ^{a, b}	А
Pulsed Drain Current (t = 300 μs)		I _{DM}	6	
Ocalia a a Ocala Baila Bioda Ocala	T _C = 25 °C		0.4	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	0.3	
	T _C = 25 °C		0.5	
Maximum Dawar Dissination	T _C = 70 °C		0.3	\Box w
Maximum Power Dissipation	T _A = 25 °C	P _D	0.4 ^{a, b}	VV
	T _A = 70 °C		0.3 ^{a, b}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C
Soldering Recommendations (Peak Temperature)			260	-0

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient a, d	t ≤ 10 s	R _{thJA}	250	300	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	225	270		

Notes

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Based on $T_C = 25$ °C.
- d. Maximum under steady state conditions is 360 °C/W.



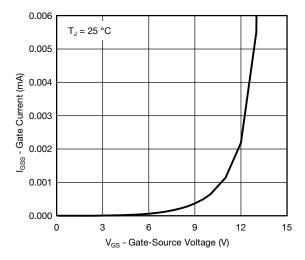
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static					l		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	20	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 A	-	32	-	mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-3	-		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.5	-	1.0	V	
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = 4.5 V	-	-	0.1	μΑ	
		V _{DS} = 0 V, V _{GS} = ± 12 V	-	-	± 20		
Zana Oata Wallana Barin O	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V	-	-	0.1		
Zero Gate Voltage Drain Current		V _{DS} = 20 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10		
On-State Drain Current ^a	I _{D(on)}	V _{DS} ≥ 5 V, V _{GS} = 10 V	2	-	-	Α	
Drain-Source On-State Resistance a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 1 A	-	0.273	0.355	_	
		V _{GS} = 2.5 V, I _D = 0.5 A	-	0.399	0.450	Ω 50	
Forward Transconductance a	9 _{fs}	V _{DS} = 10 V, I _D = 1.4 A	-	5	-	S	
Dynamic ^b				1	•	•	
Input Capacitance	C _{iss}		-	105	-	pF	
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	-	23	-		
Reverse Transfer Capacitance	C _{rss}		-	11	-		
Total Cata Charge	0	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 1.4 A	-	2.7	4.1		
Total Gate Charge	Qg		-	1.4	2.1	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1.4 \text{ A}$	-	0.3	-		
Gate-Drain Charge	Q_{gd}		-	0.5	-		
Gate Resistance	Rg	f = 1 MHz	1.4	7	14	Ω	
Turn-On Delay Time	t _{d(on)}		-	2	4		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_L = 13.6 \Omega$	-	9	18	70	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.1 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	8	16		
Fall Time	t _f		-	8	16		
Turn-On Delay Time	t _{d(on)}		-	8	16	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_L = 13.6 \Omega$	-	13	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.1 \text{ A, } V_{GEN} = 4.5 \text{ V, } R_g = 1 \Omega$	-	15	23		
Fall Time	t _f		-	6	12		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C		-	0.4	А	
Pulse Diode Forward Current ^a	I _{SM}		-	-	6	^	
Body Diode Voltage	V_{SD}	I _F = 1.1 A	-	0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}		-	8	16	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I_ = 1.1 A dl/dt = 100 A/us T_ = 25 °C	-	3	6	nC	
Reverse Recovery Fall Time	ta	$I_F = 1.1 \text{ A, dl/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 °\text{C}$	_	5		no	
Reverse Recovery Rise Time	t _b		-	3	-	ns	

Notes

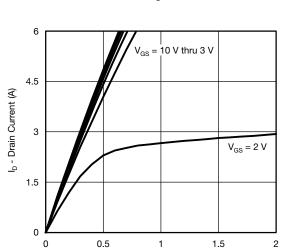
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



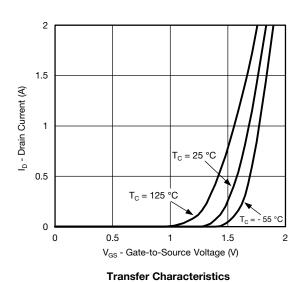


Gate Source Voltage vs. Gate Current



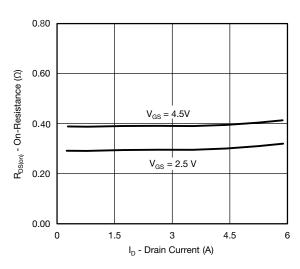
V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics

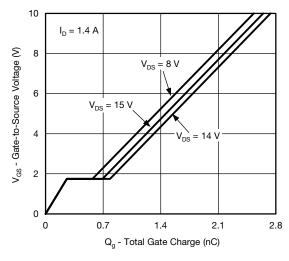


 10^{-3} 10^{-4} 10^{-4} 10^{-5} 10^{-6} 10^{-6} 10^{-8} 10^{-9} $10^{$

Gate Source Voltage vs. Gate Current

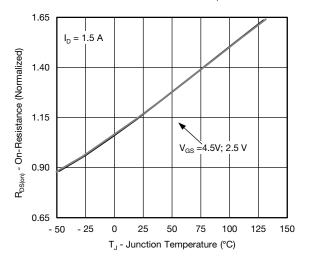


On-Resistance vs. Drain Current

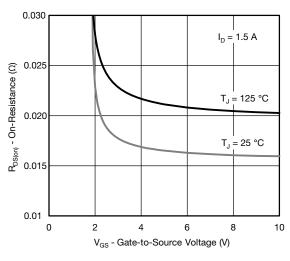


Gate Charge

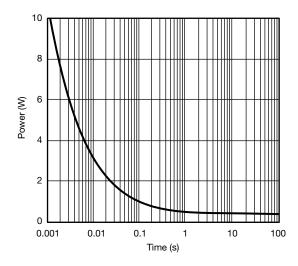




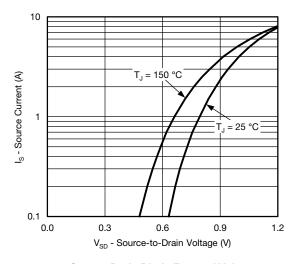
On-Resistance vs. Junction Temperature



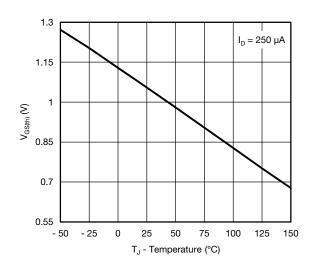
On-Resistance vs. Gate-to-Source Voltage



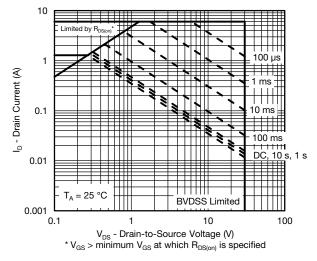
Single Pulse Power, Junction-to-Ambient



Source-Drain Diode Forward Voltage

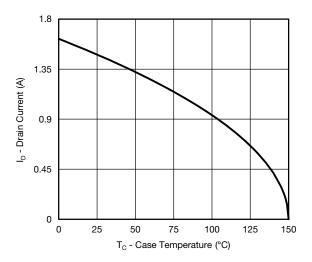


Threshold Voltage

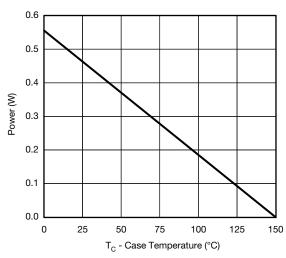


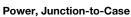
Safe Operating Area, Junction-to-Ambient

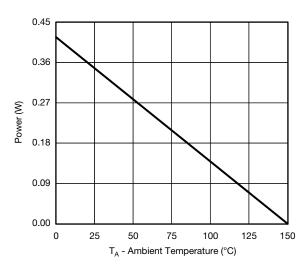




Current Derating*



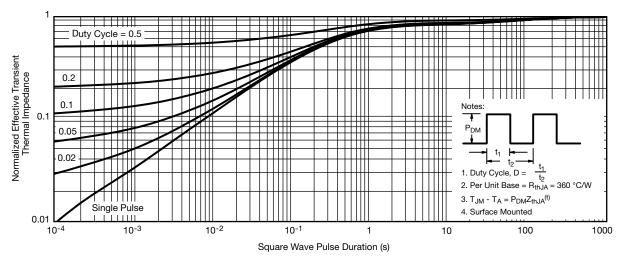




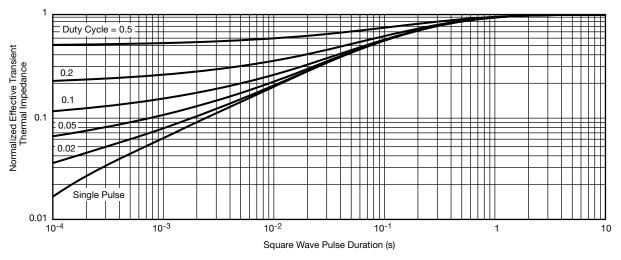
Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J \text{ (max.)}} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot





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